

# **MOSFET** - Power, Single **N-Channel**

80 V, 9.4 mΩ, 64 A

## **NVMFS6H848N**

#### **Features**

- Small Footprint (5x6 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- NVMFS6H848NWF Wettable Flank Option for Enhanced Optical
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halide Free, and are RoHS Compliant

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	80	V
Gate-to-Source Voltage	€		V <sub>GS</sub>	±20	V
Continuous Drain	Steady State	T <sub>C</sub> = 25°C	I <sub>D</sub>	57	Α
Current R <sub>0JC</sub> (Notes 1, 3)	State	T <sub>C</sub> = 100°C		40	
Power Dissipation		T <sub>C</sub> = 25°C	P <sub>D</sub>	73	W
R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 100°C		37	
Continuous Drain Current R <sub>0,JA</sub>	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	13	Α
(Notes 1, 2, 3)	State	T <sub>A</sub> = 100°C	1	9.0	
Power Dissipation	T <sub>A</sub> = 25°C		$P_{D}$	3.7	W
R <sub>θJA</sub> (Notes 1, 2)		T <sub>A</sub> = 100°C		1.8	
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I <sub>DM</sub>	308	Α
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C
Source Current (Body Diode)			I <sub>S</sub>	61	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 8.2 A)			E <sub>AS</sub>	278	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

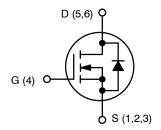
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	2.0	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	41	

- 1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
80 V	9.4 mΩ @ 10 V	64 A



**N-CHANNEL MOSFET** 

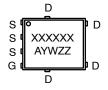




DFN<sub>5</sub> (SO-8FL) CASE 488AA STYLE 1

**DFNW5 5x6** (FULL-CUT SO8FL WF) CASE 507BA

#### **MARKING DIAGRAM**



XXXXXX = 6H848N

(NVMFS6H848N) or

848NWF

(NVMFS6H848NWF)

= Assembly Location

= Year

W

= Work Week

= Lot Traceability

#### ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condi	tion	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•	•					•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu$	A	80			٧
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				39		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			10	μΑ
		V <sub>DS</sub> = 80 V	T <sub>J</sub> = 125°C			100	1
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = 20 \text{ V}$	V			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 70 μ	A	2.0		4.0	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-7.3		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 10 A		8.1	9.4	mΩ
Forward Transconductance	9 <sub>F</sub> s	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 20 A			52		S
CHARGES, CAPACITANCES & GATE R	ESISTANCE						
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 40 V			1180		pF
Output Capacitance	C <sub>OSS</sub>				170		
Reverse Transfer Capacitance	C <sub>RSS</sub>				8.0		1
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 40 V; I <sub>D</sub> = 20 A			16		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 40 V; I <sub>D</sub> = 20 A			3.1		
Gate-to-Source Charge	Q <sub>GS</sub>				4.8		
Gate-to-Drain Charge	$Q_{GD}$				2.8		
Plateau Voltage	V <sub>GP</sub>				4.5		V
SWITCHING CHARACTERISTICS (Note	5)						
Turn-On Delay Time	t <sub>d(ON)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 64			13		ns
Rise Time	t <sub>r</sub>	$I_D = 20 \text{ A}, H_G = 2.5 \Omega$	$I_D = 20 \text{ A}, R_G = 2.5 \Omega$		33		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>				34		
Fall Time	t <sub>f</sub>				23		1
DRAIN-SOURCE DIODE CHARACTERI	STICS						
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V$	T <sub>J</sub> = 25°C		0.8	1.2	V
		I <sub>S</sub> = 10 A	T <sub>J</sub> = 125°C		0.7		1
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dIS/dt = 100 A/μs, I <sub>S</sub> = 20 A			39		ns
Charge Time	t <sub>a</sub>				25		1
Discharge Time	t <sub>b</sub>				14		1
Reverse Recovery Charge	Q <sub>RR</sub>				41		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.

<sup>5.</sup> Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**

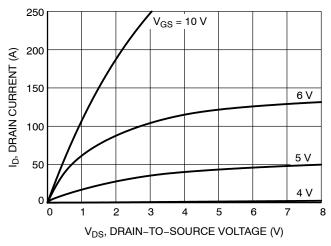


Figure 1. On-Region Characteristics

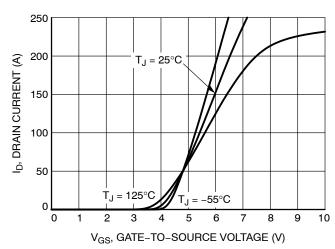


Figure 2. Transfer Characteristics

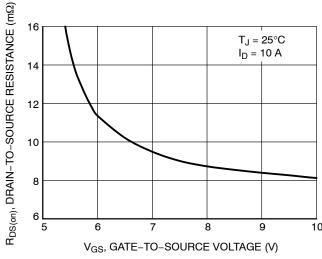


Figure 3. On-Resistance vs. Gate-to-Source Voltage

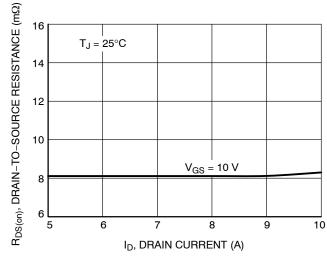


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

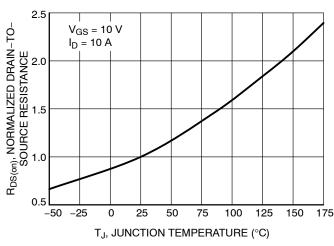


Figure 5. On–Resistance Variation with Temperature

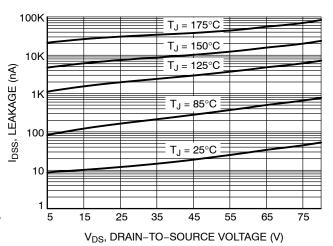


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### TYPICAL CHARACTERISTICS (continued)

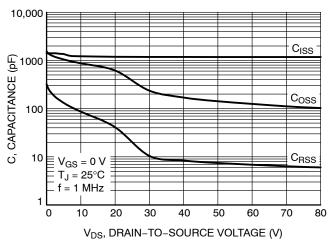


Figure 7. Capacitance Variation

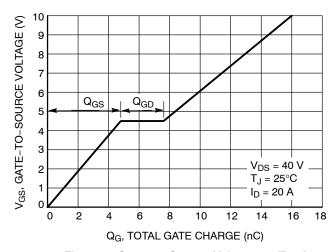


Figure 8. Gate-to-Source Voltage vs. Total Charge

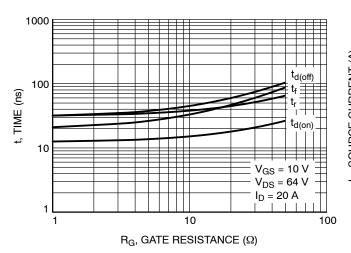


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

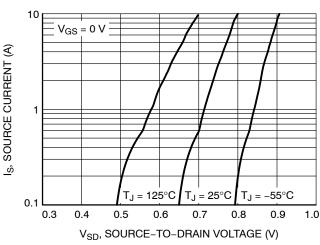


Figure 10. Diode Forward Voltage vs. Current

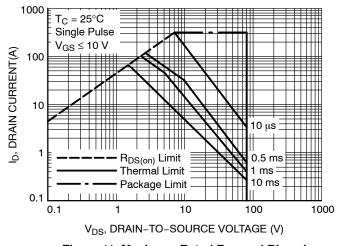


Figure 11. Maximum Rated Forward Biased Safe Operating Area

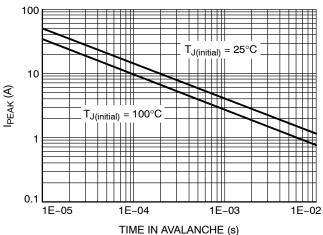


Figure 12. I<sub>PEAK</sub> vs. Time in Avalanche

#### TYPICAL CHARACTERISTICS (continued)

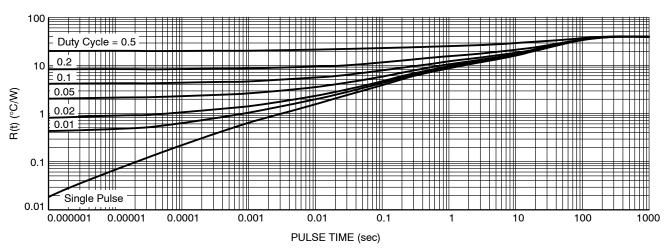


Figure 13. Thermal Characteristics

#### **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NVMFS6H848NT1G	6H848N	DFN5 (Pb-Free, Halide Free)	1500 / Tape & Reel
NVMFS6H848NWFT1G	848NWF	DFNW5 (Pb-Free, Halide Free, Wettable Flanks)	1500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, <a href="https://example.com/BRD8011/D">BRD8011/D</a>.





0.10

SIDE VIEW

DFN5 5x6, 1.27P (SO-8FL) CASE 488AA ISSUE N

**DATE 25 JUN 2018** 

#### NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETER. DIMENSION D1 AND E1 DO NOT INCLUDE
- MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS			
DIM	MIN	NOM	MAX	
Α	0.90	1.00	1.10	
A1	0.00	-	0.05	
b	0.33	0.41	0.51	
С	0.23	0.28	0.33	
D	5.00	5.15	5.30	
D1	4.70	4.90	5.10	
D2	3.80	4.00	4.20	
E	6.00	6.15	6.30	
E1	5.70	5.90	6.10	
E2	3.45	3.65	3.85	
е	1.27 BSC			
G	0.51	0.575	0.71	
K	1.20	1.35	1.50	
L	0.51	0.575	0.71	
L1	0.125 REF			
M	3.00	3.40	3.80	
θ	0 °		12 °	

#### **GENERIC MARKING DIAGRAM\***



XXXXXX = Specific Device Code

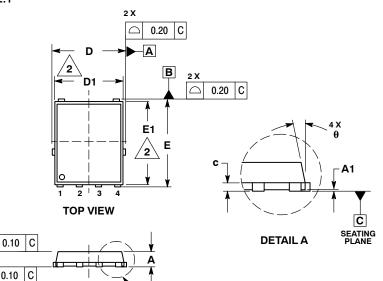
= Lot Traceability

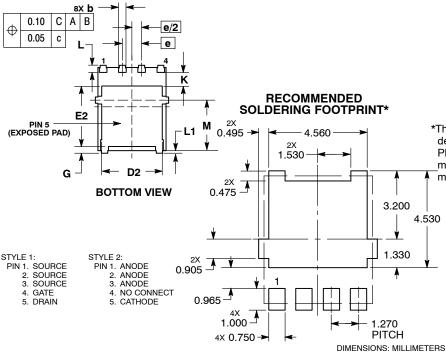
= Assembly Location Α

Υ = Year W = Work Week

ZZ

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ", may or may not be present. Some products may not follow the Generic Marking.





**DETAIL** A

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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**IDENTIFIER** 





CASE 507BA **ISSUE A** 



**MILLIMETERS** 

N□M.

0.575

0.575

0.150 REF

1.35

MAX. 1.10 0.05 0.51

0.33

5.30 5.10

4.20

6.30 6.10

3.85

0.71

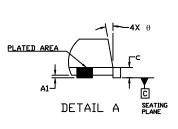
1.50

0.71



DIM

DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
CONTROLLING DIMENSION: MILLIMETERS
DIMENSIONS DI AND EI DO NOT INCLUDE MOLD FLASH,
PROTRUSIONS, OR GATE BURRS.
THIS PACKAGE CONTAINS WETTABLE FLANK DESIGN
FEATURES TO AID IN FILLET FORMATION ON THE LEADS DURING MOUNTING.



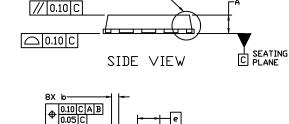
Α	0.90	1.00
A1	0.00	
b	0.33	0.41
С	0.23	0.28
D	5.00	5.15
D1	4.70	4.90
D2	3.80	4.00
Е	6.00	6.15
E1	5.70	5.90
E2	3.45	3.65
е		1.27 BSC

0.51

1.20

0.51

MIN



e/2

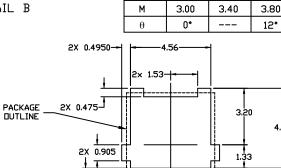
BOTTOM VIEW

-DETAIL B

DETAIL A

TOP VIEW





0.965

4X 1.00-

G

Κ

L1

#### **GENERIC** MARKING DIAGRAM\*

PIN 5 (EXPOSED PAD)



= Assembly Location Α

Υ = Year W

ZZ

= Work Week = Lot Traceability

XXXXXX = Specific Device Code \*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " =", may or may not be present. Some products

may not follow the Generic Marking.

RECOMMENDED MOUNTING FOOTPRINT

For additional information on our Pb-Free strategy and soldering details, please download the  $\square N$ Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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**DESCRIPTION:** DFNW5 5x6 (FULL-CUT SO8FL WF) **PAGE 1 OF 1** 

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